



TEST REPORT

KCTL Inc.

65, Sinwon-ro, Yeongtong-gu,
Suwon-si, Gyeonggi-do, 16677, Korea
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Report No.:
KR21-SRF0155-C
Page (1) of (12)

KCTL

1. Client

- Name : TOVIS CO., LTD.
- Address : 92, Gaetbeol-ro, Yeonsu-Gu, Incheon, Korea
- Date of Receipt : 2021-06-10

2. Use of Report : Certification

3. Name of Product / Model : Wireless Charger Module / PTM-520K

4. Manufacturer / Country of Origin : POWER CAST CO., LTD. / Korea

5. FCC ID : 2A2GT-PTM-520K

6. Date of Test : 2021-06-30 to 2021-07-22

7. Location of Test : ☒ Permanent Testing Lab ☐ On Site Testing
(Address: 65, Sinwon-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Korea)

8. Test method used : 47 CRF Part 1.1310

9. Test Result : Refer to the test result in the test report

Affirmation	Tested by	Technical Manager
	Name : Euijung Kim  (Signature)	Name : Hyeonsu Jang  (Signature)

2021-08-24

KCTL Inc.

As a test result of the sample which was submitted from the client, this report does not guarantee the whole product quality. This test report should not be used and copied without a written agreement by KCTL Inc.

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REPORT REVISION HISTORY

Date	Revision	Page No
2021-07-15	Originally issued	-
2021-07-22	Updated	5, 10, 11
2021-08-18	Updated	1, 10, 11
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Note. The report No. KR21-SRF0155-B is superseded by the report No. KR21-SRF0155-C.

General remarks for test reports

Statement concerning the uncertainty of the measurement systems used for the tests

(may be required by the product standard or client)

☐ Internal procedure used for type testing through which traceability of the measuring uncertainty has been established:

Procedure number, issue date and title:

Calculations leading to the reported values are on file with the testing laboratory that conducted the testing.

☒ Statement not required by the standard or client used for type testing

CONTENTS

1.	General information	4
2.	Device information	4
2.1.	Host device information	5
2.2.	Accessory information	5
2.3.	Frequency/channel operations.....	5
3.	Measurement uncertainty	5
4.	RF Exposure.....	6
4.1.	FCC Regulation	6
4.2.	Test Set-up.....	7
4.3.	Test configuration (Description of test mode).....	9
4.4.	Test result	10
5.	Measurement Equipment.....	12

1. General information

Client : TOVIS CO., LTD.
 Address : 92, Gaetbeol-ro, Yeonsu-Gu, Incheon, Korea
 Manufacturer : POWER CAST CO., LTD.
 Address : #1025, 220, Bugwang-ro, Bucheon-si, Gyeonggi-do, Republic of Korea
 Laboratory : KCTL Inc.
 Address : 65, Sinwon-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Korea
 Accreditations : FCC Site Designation No: KR0040, FCC Site Registration No: 687132
 VCCI Registration No. : R-20080, G-20078, C-20059, T-20056
 CAB Identifier: KR0040, ISED Number: 8035A
 KOLAS No.: KT231

2. Device information

Equipment under test : Wireless Charging Module
 Model : PTM-520K
 Modulation technique : ASK
 Frequency range : 110 kHz ~ 129 kHz
 Power source : DC 5 V
 Antenna specification : Coil Antenna
 Software version : 0.1
 Hardware version : 0.1
 Test device serial No. : N/A
 Operation temperature : -30 °C ~ 45 °C

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2.1. Host device information

Equipment	Manufacturer	Model	Serial No.
Gaming LCD Monitor	TOVIS CO., LTD.	L1946BPSKN	R200224SPL001

2.2. Accessory information

Equipment	Manufacturer	Model	Serial No.	FCC ID
Smart Phone	Samsung Electronics Co., Ltd.	SM-G998N	-	-

2.3. Frequency/channel operations

This device contains the following capabilities:

WPT

Frequency (kHz)
110 ~ 129

Table 2.3.1. WPT

3. Measurement uncertainty

The measurement uncertainties shown below were calculated in accordance with the requirements of ANSI C63.10-2013.

All measurement uncertainty values are shown with a coverage factor of $k=2$ to indicated a 95 % level of confidence. The measurement data shown herein meets or exceeds the U_{CISPR} measurement uncertainty values specified in CISPR 16-4-2 and thus, can be compared directly to specified limits to determine compliance.

Parameter	Expanded uncertainty ($\pm$)	
Conducted RF power	1.3 dB	
E-Field	3 kHz ~ 10 MHz	11.04 %
H-Field	3 kHz ~ 10 MHz	13.80 %

4. RF Exposure

4.1. FCC Regulation

This document is prepared to show compliance with the RF Exposure requirements as required in §1.1310 of the FCC rules and Regulations.

The limit for Maximum Permissible Exposure (MPE), specified in FCC §1.1310, is listed in Table 1-1. According to FCC §1.1310: the criteria listed in the following table shall be used to evaluate the environmental impact of human exposure to radio-frequency (RF) radiation as specified in §1.1307(b).

Table 1 – Limits for Maximum Permissible Exposure (MPE)

Frequency Range (MHz)	Electric Field Strength [V/m]	Magnetic Field Strength [A/m]	Power Density [mW/cm ²]	Averaging Time [minute]
(A) Limits for Occupational / Controlled Exposure				
0.3 ~ 3.0	614	1.63	*100	6
3.0 ~ 30	1842/f	4.89/f	*900/f ²	6
30 ~ 300	61.4	0.163	1.0	6
300 ~ 1 500	/	/	f/300	6
1 500 ~ 15 000	/	/	5	6
(B) Limits for General Population / Uncontrolled Exposure				
0.3 ~ 1.34	614	1.63	*100	30
1.34 ~ 30	824/f	2.19/f	*180/f ²	30
30 ~ 300	27.5	0.073	0.2	30
300 ~ 1 500	/	/	f/1 500	30
1 500 ~ 15 000	/	/	1.0	30

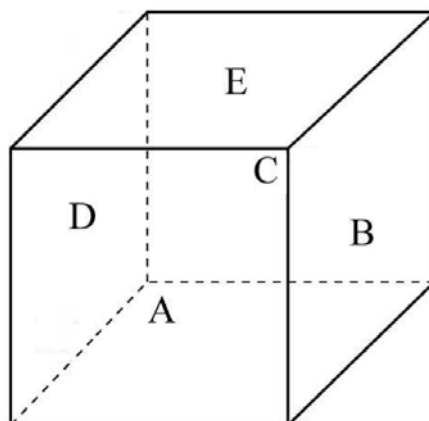
f=frequency in MHz, * = plane-wave equivalent power density

Per the guidance of KDB 680106, the E-field and H-field limits shown in the table above are extended down to 100 kHz

4.2. Test Set-up

4.2.1. Isotropic Probe test setup

The measurement probe (EHP-200A) is a regular hexahedron and supports 3-axis (X, Y and Z) isotropic probe.



A: Front of measurement probe

B: Right of measurement probe

C: Rear of measurement probe

D: Left of measurement probe

E: Top of measurement probe

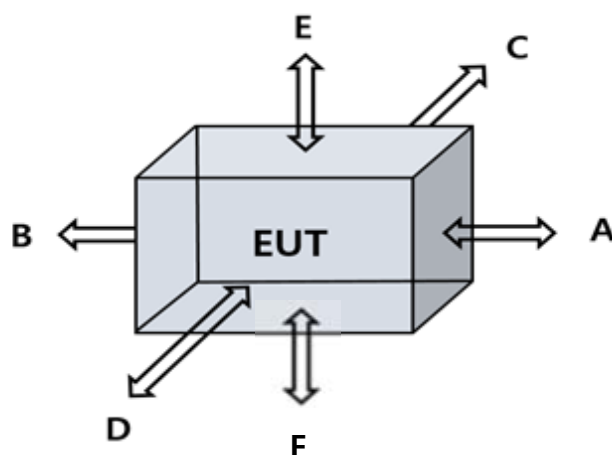
*Bottom of measurement probe is not used to measure RF exposure condition owing to connection with a stick.

At 0 cm distance, measurement isotropic probe was investigated by rotating the probe through various angles for one of the EUT's sides as below.

Measurement Point	A	B	C	D	E
Direction	Front	Right	Rear	Left	Top
Measurement Point	A to B	B to C	C to D	D to A	N/A
Direction	Front to Right	Right to Rear	Rear to Left	Left to Front	-
Measurement Point	A to E	B to E	C to E	D to E	N/A
Direction	Front to Top	Right to Top	Rear to Top	Left to Top	-

When the worst angle among all angles was found, RF exposure measurement should be adjusted from worst angle.

4.2.2. EUT test setup



- 1) Testing was performed with a calibrated field probe.
- 2) Measurement was performed on each side of the EUT as described per below table.

A	B	C	D	E	F
Front	Rear	Right	Left	Top	Bottom

Measurement Probe	EHP-200A (Manufacturer: Narda)
Measurement Method	Direct measurement
Measurement Distance	Surface of the EUT to the center of the probe.

Equipment Approval Considerations item 5.b) of KDB 680106 D01 v03

- a) Power transfer frequency is less than 1 MHz.
- ▶ This device is operates at a frequency of 127.7 kHz.
- b) Output power from each primary coil is less than or equal to 15 watts.
- ▶ DC 5.0 V condition / Output power from each primary coil : 0.23 watts.
- c) The transfer system includes only single primary and secondary coils. This includes charging systems that may have multiple primary coils and clients that are able to detect and allow coupling only between individual pairs of coils.
- ▶ The transfer system includes only single primary and secondary coils.
- d) Client device is placed directly in contact with the transmitter.
- ▶ The client device is placed directly in contact with the transmitter.
- e) Mobile exposure conditions only (portable exposure conditions are not covered by this exclusion)
- ▶ This device is mobile exposure condition.
- f) The aggregate H-field strengths at 15cm surrounding the device and 20cm above the top surface from all simultaneous transmitting coils are demonstrated to be less than 50% of the MPE limit.
- ▶ The EUT field strength levels < 50 % of the MPE limit 1.63 A/m
 0.814 A/m (Max) < 0.815 A/m

4.3. Test configuration (Description of test mode)

Test case configuration is reported as below.

Test Mode	Description
TM1	EUT + Mobile phone(Battery status: < 10%)
TM2	EUT + Mobile phone(Battery status: < 50%)
TM3	EUT + Mobile phone(Battery status: > 90%)

4.4. Test result

4.4.1. Test mode: test result of rotating the probe through various angles

Distance : 15_{cm} surrounding the device and 20_{cm} above the top surface.

- E-field measurement results (Sides of probe)

E-field Measurement Results (Class 01 probe)						
Frequency [MHz]	E-field Measurement [V/m]					Limits [V/m]
	Probe rotation					
	A	B	C	D	E	
0.122	1.628 1	2.021 5	3.051 4	3.330 5	2.023 1	614.00

- H-field measurement results (Sides of probe)

H-field measurement results (Edges of probe)						
Frequency [MHz]	H-field Measurement [A/m]					Limits [A/m]
	Probe rotation					
	A	B	C	D	E	
0.122	0.311 1	0.224 8	0.128 6	0.142 8	0.192 2	0.814

- E-field measurement results (Rotation of probe)

Frequency [MHz]	E-field Measurement [V/m]								Limits [V/m]
	Probe rotation								
	A to E	B to E	C to E	D to E	A to B	B to C	C to D	D to A	
0.122	1.805 7	2.138 8	2.731 8	2.088 9	1.915 7	2.720 2	2.464 4	3.115 8	614

- H-field measurement results (Rotation of probe)

Frequency [MHz]	H-field Measurement [A/m]								Limits [A/m]
	Probe rotation								
	A to E	B to E	C to E	D to E	A to B	B to C	C to D	D to A	
0.122	0.254 7	0.282 9	0.185 1	0.147 5	0.378 9	0.344 4	0.231 6	0.268 3	0.814

Note:

- Worst Case: E-field = A-side, H-field = A to B-side.

4.4.2. Test mode: Test result of EUT's sides about the distance

Distance : 15_{cm} surrounding the device and 20_{cm} above the top surface.

- E-field measurement results

Test Mode	Frequency [MHz]	E-field Measurement [V/m]						Limits [V/m]
		EUT sides						
		A	B	C	D	E	F	
TM1	0.122	3.255 3	1.383 7	1.543 3	1.504 2	2.351 6	3.178 0	614
TM2	0.122	3.280 4	1.412 3	1.551 3	1.497 9	2.344 1	3.170 9	
TM3	0.122	3.233 8	1.407 7	1.526 4	1.491 1	2.256 3	3.218 9	

- H-field measurement results

Test Mode	Frequency [MHz]	H-field Measurement [A/m]						Limits [A/m]
		EUT sides						
		A	B	C	D	E	F	
TM1	0.122	0.388 1	0.034 8	0.036 9	0.036 0	0.221 0	0.187 0	0.814
TM2	0.122	0.389 5	0.035 0	0.035 5	0.035 0	0.225 4	0.187 3	
TM3	0.122	0.386 3	0.035 8	0.036 5	0.035 2	0.223 5	0.187 5	

Note:

- Above RF exposure measurement was performed considering worst position (A-side) of isotropic probe.

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5. Measurement Equipment

Equipment Name	Manufacturer	Model No.	Serial No.	Next Cal. Date
E&H Field Probe	narda	EHP-200A	170WX81015	22.01.29
DC Power Supply	Agilent	E3632A	MY40001543	22.05.10

End of test report